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Fully Microstrip 3-Port Circuit Bandpass NGD Design and Test

Blaise Ravelo, *Member, IEEE*, Alexandre Douyère, *Member, IEEE*, Yang Liu, Wenceslas Rahajandraibe, *Member, IEEE*, Fayu Wan, *Senior Member, IEEE*, George Chan, *Senior Member, IEEE*, and Mathieu Guerin, *Member, IEEE*

Abstract—An innovative design and test of three-port distributed circuit exhibiting double bandpass (BP) negative group delay (NGD) effect is investigated. The distributed topology is constituted by resistive transmission lines (TLs) with one input and two output accesses. The BP-NGD specifications are defined. The transfer matrix-based modelling is elaborated. The double-branch NGD theorization is based on the equivalent model of voltage transfer function (VTF) between Port₁-Port₂ and Port₁-Port₃. The VTF analytical expressions in function of TL parameters are formulated. Group delay (GD) innovative formulas are derived. The feasibility study is based on the BP-NGD design of 3-port hybrid microstrip prototype implemented on Rogers Duroid-AD1000 dielectric substrate. To validate the concept, the VTF magnitudes and GDs computed with MATLAB® are compared with commercial tool simulation and experimental results. The modelled, simulated and measured three-port circuit results show NGD responses in very good agreement. It was emphasized that the two transmission ways of the tested circuit operate with BP-NGD behavior confirmation. The measured NGD value and bandwidth of about -3.8 ns and 75 MHz at center frequency of about 0.74 GHz are obtained.

Index Terms— Bandpass (BP) negative group delay (NGD), Modelling, Design and test, Three-port microstrip circuit, Transmission line (TL), Voltage transfer function (VTF).

I. INTRODUCTION

THE TREE structure constitutes topological solution for electronic printed circuit board (PCB) designers against the integration high-density challenge [1-2]. The tree topology optimization enables to reduce the signal transition delays and power consumption [3]. General simulation method based on SPICE model was suggested to predict the multiport component behaviors [4]. But somehow analytical models are necessary for the fast estimation of tree interconnect effect before the electronic circuit design phase. Several constraints as skew effect need to be estimated with interconnect trees [5]. Generic RC-network modeling was proposed to estimate the tree effect

signal delay [6-12]. The RC meshes were used to determine the interconnect line delay sensitivity [6-7]. The RC-tree was used to implement different analog and digital electronic circuit technologies as CMOS [8-9]. A slew metric expression of RC-tree ramp input was proposed [10-11]. However, with the increase of the signal speed, the inductance effect must be considered to estimate the signal delay [12]. Equivalent model of RLC-tree interconnects was introduced [13-14]. Different topologies of tree interconnects as H- [15-19], T- [20] and YY- [21] shaped structures were suggested as clock and signal distribution networks. The H-shaped distribution network enables to synchronize the clock signal distribution [15]. An efficient design method enables to improve the design method [16,18]. The variations of interconnect parameters on the tree clock distributions were studied [17]. Beyond the RC- [6-12] and RLC- [13-14] networks, more general tree interconnect analytical modelling of microstrip structures was developed based on the transmission line (TL) approach [19-21]. The signal integrity parameters and frequency domain responses of complex tree-interconnects were assessed [19-21]. In difference to the existing tree-interconnect model, the present paper investigates bandpass (BP) negative group delay (NGD) design of 3-port microstrip circuit. So far, the performed research work on BP-NGD microstrip circuit is limited to 2-port topology [22-23]. So far, the BP-NGD circuits are commonly designed with two-port topologies. Because of theorization and design difficulties, few works are performed on BP-NGD 3-port circuit [24]. Most of NGD design researchers are failed because of design difficulties to control simultaneously the GDs through the two ways. To face up this challenge, the present study introduces BP-NGD design of distributed 3-port topology. The paper is organized in three sections. Section II focuses on the analytical modeling based on the double voltage transfer function (VTF) via transfer matrix operation. Section III presents the BP-NGD validation results from 3-port microstrip

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circuit proof-of-concept (POC). Then, Section IV is the final conclusion.

II. 3-PORT MICROSTRIP DOUBLE VTF BP-NGD MODEL

After the BP-NGD definition, the 3-port topology under study is introduced. Then, the VTF modeling is elaborated.

A. BP-NGD Specifications

By denoting the angular frequency variable, ω , the BP-NGD analysis is performed by consideration of VTF magnitude, $T(\omega) = |T(j\omega)|$, and phase, $\varphi(\omega) = \arg[T(j\omega)]$. The associated GD response is defined by:

$$GD(\omega) = -\partial\varphi(\omega)/\partial\omega. \quad (1)$$

An electric circuit behaves as a BP-NGD function if it presents cut-off frequencies, (ω_a, ω_b) , which are the roots of equation $GD(\omega) = 0$. The associated NGD bandwidth is given by $BW = f_b - f_a = (\omega_b - \omega_a)/(2\pi)$. As illustrated by ideal GD response of Fig. 1(a), the NGD center frequency, ω_n , and NGD value can be expressed as $GD_n = GD(\omega_n) < 0$ with negative value. The ideal case of magnitude response is shown by Fig. 1(b) with $T_n = T(\omega_n) < 0$ in the NGD BWs ($\omega \in BW$).

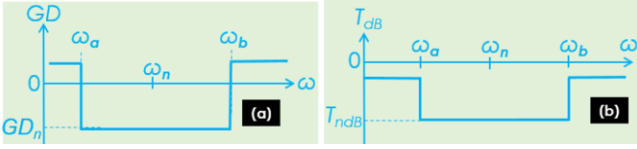


Fig. 1. BP-NGD ideal responses: (a) GD and (b) magnitude.

B. Topological Introduction of the 3-Port Structure

The 3-port topology under study is introduced by Fig. 2(a). It is constituted by input port, ①, referenced by node M_1 connected to series resistor, Z , to the middle node, M_0 . The input current injected at port ① is denoted I_1 . The two output branches, M_0M_2 , to port ②, with TL $TL_x(R_x, t_x)$ and M_0M_3 , to port ③, with TL $TL_y(R_y, t_y)$ which are terminated by shunt resistor, R . The TLs are specified by their characteristic impedance, $R_{x,y}$, and propagation delay, $t_{x,y}$. The input current injected at port ② (resp. ③) is denoted I_2 (resp. I_3).

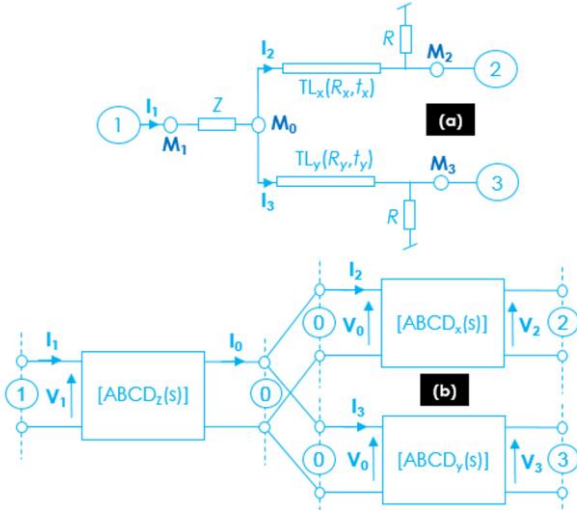


Fig. 2. (a) 3-port circuit topology under study and (b) its equivalent diagram.

By taking Laplace variable, $s=j\omega$, the equivalent model of the 3-port structure introduced by Fig. 2(b) is composed of transfer matrix constituting:

- Input branch, M_1M_0 : $[ABCD_Z(s)] = \begin{bmatrix} 1 & Z \\ 0 & 1 \end{bmatrix}$ (2)

- Output branch, M_0M_2 (with $x = a \exp(-t_x s)$):

$$[ABCD_x(s)] = \frac{1}{2a x} \begin{bmatrix} 1 + a^2 x^2 & (1 - a^2 x^2)/R_x \\ R_x(1 - a^2 x^2) & 1 + a^2 x^2 \end{bmatrix} \quad (3)$$

- Output branch, M_0M_3 (with $y = a \exp(-t_y s)$):

$$[ABCD_y(s)] = \frac{1}{2a y} \begin{bmatrix} 1 + a^2 y^2 & (1 - a^2 y^2)/R_y \\ R_y(1 - a^2 y^2) & 1 + a^2 y^2 \end{bmatrix} \quad (4)$$

- And shunt resistor: $[ABCD_R(s)] = \begin{bmatrix} 1 & 0 \\ 1/R & 1 \end{bmatrix}$ (5)

The operation between these transfer matrices enables to determine the ways ①-② and ①-③ VTFs in the following subsection.

C. VTF Expressions and BP NGD Existence

Let us generalize the transfer matrix of each branch, with $m=\{2,3\}$, as:

$$\begin{bmatrix} V_1 \\ I_1 \end{bmatrix} = [ABCD^{1 \rightarrow m}] \begin{bmatrix} V_m \\ 0 \end{bmatrix} \quad (6)$$

By definition, the VTFs between input-output port of the structure shown by Figs. 1 are expressed by:

$$TF_{m=\{2,3\}}(s) = V_m(s)/V_1(s) = 1/ABCD_{11}^{1 \rightarrow m}(s). \quad (7)$$

To determine the detailed expression, we can proceed with the transfer matrix product:

$$\begin{bmatrix} V_1 \\ I_1 \end{bmatrix} = [ABCD_Z] [ABCD_{Z_y}] [ABCD_x] [ABCD_R] \begin{bmatrix} V_2 \\ 0 \end{bmatrix} \quad (8)$$

$$\begin{bmatrix} V_1 \\ I_1 \end{bmatrix} = [ABCD_Z] [ABCD_{Z_x}] [ABCD_y] [ABCD_R] \begin{bmatrix} V_3 \\ 0 \end{bmatrix}. \quad (9)$$

Transfer matrices $[ABCD_{Zin,x}]$ and $[ABCD_{Zin,y}]$ represent the generalized expression of parallel input impedances with subscript, $\zeta=\{x,y\}$:

$$Z_\zeta(s) = \frac{R_x [R(1 + \zeta^2) + R_x(1 - \zeta^2)]}{R(1 - \zeta^2) + R_x(1 + \zeta^2)}. \quad (10)$$

Therefore, we have the VTFs:

$$TF_2(s) = \frac{2R_x R_y R_x [R_y(1 - y^2) + R(1 + y^2)]}{R^2(R_y - R_x)(x^2 - 1)(1 + y^2) + R_x^2 R_y^2 (x^2 - 1)(y^2 - 1)} + R \begin{Bmatrix} R_x^2(x^2 - 1)(1 - y^2) - R_x R_y(1 + x^2)(1 + y^2) \\ -R_y^2(1 - x^2)(1 + y^2) \end{Bmatrix} \quad (11)$$

$$TF_3(s) = \frac{2R_x R_y R_y [R_x(1 - x^2) + R(1 + x^2)]}{R^2(R_x - R_y)(y^2 - 1)(1 + x^2) + R_x^2 R_y^2 (x^2 - 1)(y^2 - 1)} + R \begin{Bmatrix} R_y^2(y^2 - 1)(1 - x^2) - R_x R_y(1 + x^2)(1 + y^2) \\ -R_x^2(1 - y^2)(1 + x^2) \end{Bmatrix} \quad (12)$$

The BP-NGD analysis is based on VTF magnitude, $TF_m(\omega) = |TF_m(j\omega)|$, and phase, $\varphi_m(\omega) = \arg[TF_m(j\omega)]$. The associated GD is determined by:

$$GD_m(\omega) = -\partial\varphi_m(\omega) / \partial\omega. \quad (13)$$

For the sake of mathematical simplification, the following NGD analysis is performed under the case, $R_x = R_y = R_0$. We can demonstrate that at quarter wavelength angular frequencies:

$$\omega_x = \pi / (4t_x) \quad (14)$$

$$\omega_y = \pi / (4t_y) \quad (15)$$

The transmission way ①-② TF magnitude is expressed as:

$$TF_2(\omega_x) = \frac{\sqrt{2R_0R[R^2(1+\xi^2)+R_0^2(1-\xi^2)]}}{\sqrt{R^2R+R_0^2(Z-R)-R_0^3+2R_0RZ+\xi[R_0^3-R_0^2R+(R-R_0)^2Z]+(R-R_0)^2[R_0^2+Z(R_0-R)]}}. \quad (16)$$

with $\xi = \cos(\pi t_y / t_x)$. The corresponding GD, $GD_x = GD(\omega_x)$ corresponding to transmission way ①-② is given by:

$$GD_x = \frac{\xi^2(R^2-R_0^2)^2[R^2Z+R_0^2(Z-R)]+R_0\xi\left\{ZR^4-R^3[(R^2+Z^2)t_x+Z^2t_y]+R^2R_0^2Z(4t_x+t_y)\right\}-R_0^2R[(R_0^2+Z^2)t_x+3Z^2t_y]+R_0^4Z(t_x+t_y)+[\xi(R^2-R_0^2)+R_0^2+R^2]\{R^6R_0Zt_x-R_0^4R^4(R+R_0)[(R_0^2+4Z^2)t_x+2Z^2t_y]+R^4R_0^3Z(7t_x+2t_y)-2R_0^3R^3[(R_0^2+4Z^2)t_x-2Z^2t_y]\}}{[\xi(R^2-R_0^2)[(RZ-R_0^2)^2-Z^2R_0^2]-2R_0^2RZ(R^2+3R_0^2)+Z^2(R^4+6R^2R_0^2+R_0^4)+R_0^4(R^2+R_0^2)]}. \quad (17)$$

The way ①-③ VTF magnitude is written as:

$$TF_3(\omega_y) = \frac{\sqrt{2R_0R[R^2(1+\cos(\pi t_x/t_y)^2)+R_0^2(1-\cos(\pi t_x/t_y)^2)]}}{\sqrt{R^2R+R_0^2(Z-R)-R_0^3+2R_0RZ+\cos(\pi t_x/t_y)[R_0^3-R_0^2R+(R-R_0)^2Z]+(R-R_0)^2[R_0^2+Z(R_0-R)]}}. \quad (18)$$

By analogy, the way ①-③ GD can be written by substituting t_x and t_y of the last equation. By taking $\zeta = \cos(\pi t_x / t_y)$, the GD associated to three-port circuit way ①-③ is given by (19).

To verify the BP-NGD 3-port circuit theory feasibility, PoC, prototyping and experimental investigation will be presented in the next section.

$$GD_y = GD(\omega_y) = \frac{\left\{ \zeta^2(R^2-R_0^2)^2[R^2Z+R_0^2(Z-R)]+R_0\xi\left\{ZR^4-R^3[(R^2+Z^2)t_y+Z^2t_x]+R^2R_0^2Z(4t_y+t_x)\right\}-R_0^2R[(R_0^2+Z^2)t_y+3Z^2t_x]+R_0^4Z(t_x+t_y)\right\}+[\zeta(R^2-R_0^2)+R_0^2+R^2]\{R^6R_0Zt_y-R_0^4R^4(R+R_0)[(R_0^2+4Z^2)t_y+2Z^2t_x]+R^4R_0^3Z(7t_y+2t_x)-2R_0^3R^3[(R_0^2+4Z^2)t_y-2Z^2t_x]+R_0^5R^2Z(7t_y-4t_x)+R_0^7Z(t_y+2t_x)\}}{\left\{ \zeta(R^2-R_0^2)[(RZ-R_0^2)^2-Z^2R_0^2]+Z^2(R^4+6R^2R_0^2+R_0^4)+R_0^4(R^2+R_0^2)-2R_0^2RZ(R^2+3R_0^2) \right\}}. \quad (19)$$

III. SIMULATED AND EXPERIMENTAL VALIDATIONS

The present section introduces the 3-port microstrip circuit BP-NGD validation. After the PoC description, the calculated, simulated and measured results will be discussed.

A. PoC Design Description

The 3-port circuit prototype was implemented on Cu-metalized ARLON AD1000 dielectric substrate in hybrid technology with 0603 SMD resistors. The substrate characteristics are addressed in Table I. The circuit prototype introduced was designed and fabricated with the parameters indicated in the table last row. Fig. 3(a) shows the designed circuit layout from the electronic and RF/microwave circuit simulator ADS® from Keysight Technologies®. Fig. 3(b) shows the corresponding photo.

TABLE I
CIRCUIT AND SUBSTRATE PHYSICAL PARAMETERS

Structure	Description	Parameters	Values
Substrate	Relative permittivity	ϵ_r	10.2
	Loss tangent	$\tan(\delta)$	0.0023
	Thickness	h	762 μm
Metallization conductor	Copper conductivity	σ	58 MS/s
	Thickness	t	35 μm
Access line	Length	d	5 mm
TL _x	Length	d_x	36.2 mm
	Propagation delay	t_x	0.37 ns
TL _y	Length	d_y	32.1 mm
	Propagation delay	t_y	0.335 ns
All TLs	Width	w	0.68 mm
	Characteristic impedance	$R_x=R_y=R_0$	50 Ω
Resistor		R	10 Ω
		Z	1 k Ω

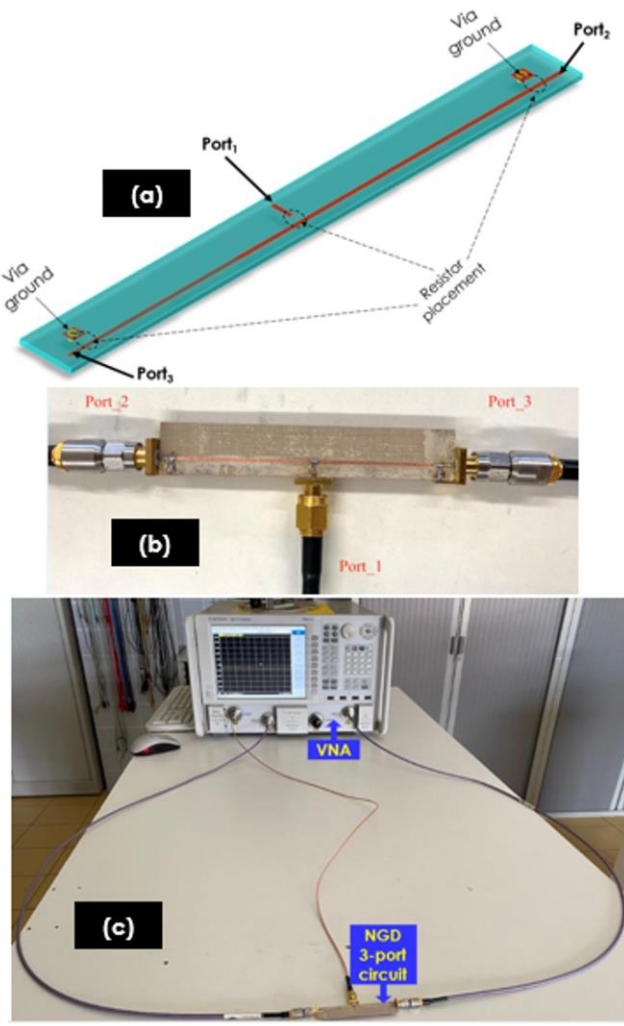


Fig. 3. (a) Layout, (b) photograph and (c) experimental setup of the NGD 3-port circuit prototype.

The fabricated circuit prototype has physical sizes 77 mm × 9 mm. The S-parameter measurement is based on recorded in touchstone data as illustrated by the experimental setup illustrated by Fig. 3(c). The test was carried out by using Vector Network Analyzer (VNA) referenced, N5241A PNA-X Microwave Network Analyzer, 10 MHz to 13.5 GHz, with SMA 85052D SOLT calibration kit. The BP-NGD experimental validation is explored in the next subsection.

B. Validation Results

We emphasize that the calculated results of the 3-port circuit POC were obtained with MATLAB programming of VTF magnitude established in equations (11) and (12), and GD. The sensitivity analyses with respect to the TL parameters are examined in the following paragraph.

1) Sensitivity Analyses with Respect to the TL Characteristic Impedances and Propagation Delays

This sensitivity analyses were performed by varying linearly and individually Z , R and w between +/-10% of their nominal values. Fig. 4(a), 4(b) and 4(c) represent the mappings of GD_x in function of the couple frequency and Z , R and w , respectively. Figs. 5 display the corresponding magnitudes. We can understand from the cartographies that the BP NGD function is still conserved despite the parametric variations. Based on Figs.

4, the GD responses are less sensitive to R and Z variation compared to w . The minimal and maximal values of NGD center frequency, bandwidth, value and the VTF attenuation are addressed by Table II. It can be seen that f_n is insensitive to Z and R variations. However, the NGD absolute value $|GD_n|$ decreases when Z , R and w increase.

TABLE II
MIN AND MAX OF BP NGD PARAMETERS VERSUS Z , R AND w

	Parameter	f_n (MHz)	BW (MHz)	GD_n (ns)	$TF_x(f_n)$ (dB)
min	Z	744	78	-3.265	-0.632
	R			-3.245	-0.199
	w			-3.511	-0.543
max	Z	744	78	-3.155	0.495
	R			-3.178	0.012
	w			-2.907	0.423

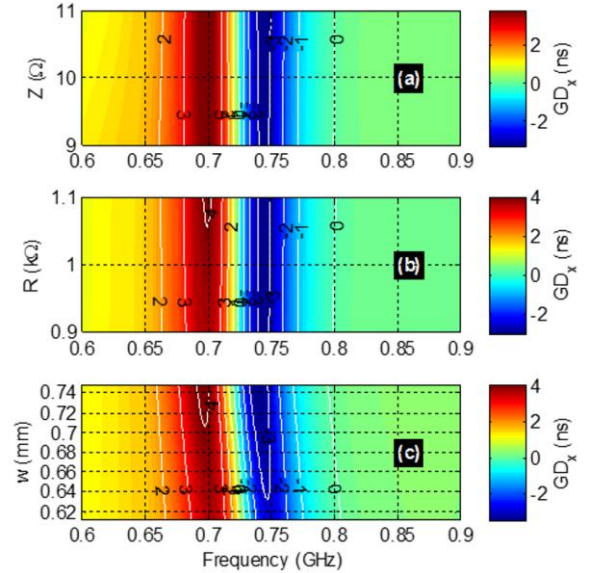


Fig. 4. GD_x mappings versus frequency and (a) Z , (b) R and (c) w .

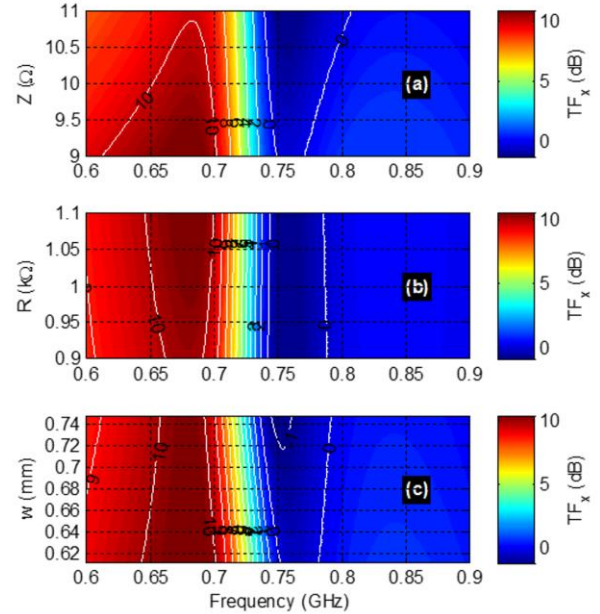


Fig. 5. TF_x magnitude mappings versus frequency and (a) Z , (b) R and (c) w .

2) Discussion on Calculated, Simulated and Measured Results

The calculated, simulated, and measured VTF magnitudes of the 3-port circuit prototype through ways ①-② and ①-③ are plotted in Figs. 6(a), and 6(b). It can be seen from these figures that in the NGD frequency band, the attenuation is higher than

-3 dB through way ①-② and higher than -1 dB through way ①-③. Comparisons between the calculated (“Calc.”), simulated (“Simu.”) with ADS®, and measured (“Meas.”) results were carried out in the frequency band from 0.6 GHz to 0.9 GHz. It can be emphasized that the VTF GDs present a BP-NGD behavior. The corresponding GDs through ways ①-② and ①-③ are displayed by Figs. 6(c) and Fig. 6(d), respectively. It can be pointed out that these comparative results present a very good agreement. The measured NGD center frequency of transmission through ways ①-② and ①-③ are approximately $f_{n①-②}=737$ MHz and $f_{n①-③}=667$ MHz. Table III summarizes the differences between the calculated, simulated and measured NGD parameters.

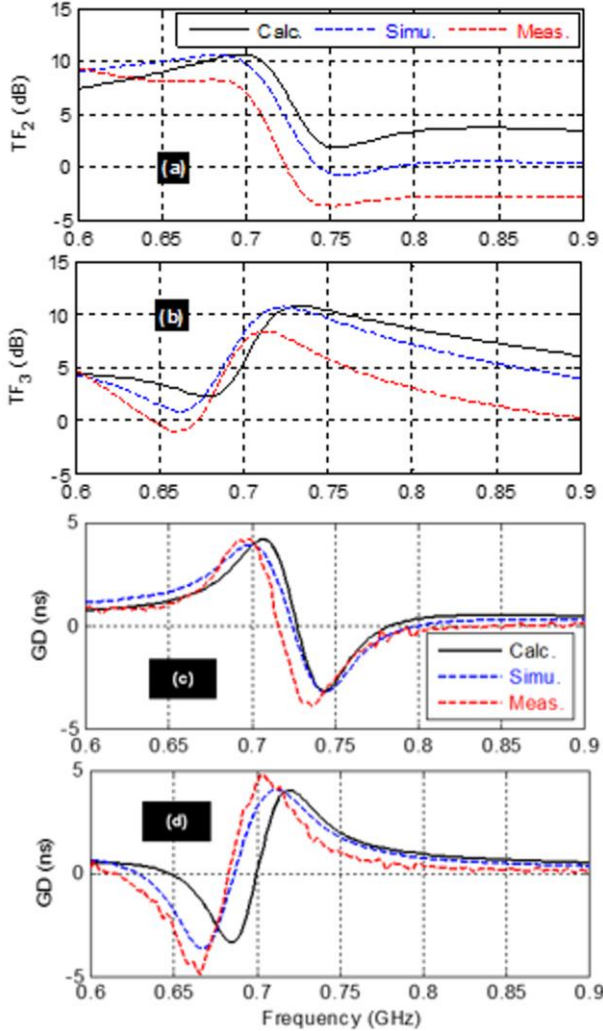


Fig. 6. Comparisons of calculated, simulated, and measured VTF magnitudes through way (a) ①-② and (b) ①-③, and GDs through way (c) ①-② and (d) ①-③ of 3-port BP-NGD prototype.

TABLE III
COMPARISON OF BP NGD SPECIFICATIONS

Approach	Way	f_n (MHz)	$GD(f_n)$ (ns)	BW (MHz)	$T(f_n)$ (dB)
Calc.	①-②	745	-3.15	56	2.07
Simu.		745	-3.21	76	-0.3
Meas.		737	-3.87	78	-3.11
Calc.	①-③	687	-3.35	50	2.87
Simu.		669	-3.65	56	1.1
Meas.		667	-4.9	64	-0.63

The slight frequency shifts of NGD center frequency are mainly due to the fabrication inaccuracies, substrate effective permittivity tolerance, and losses versus the numerical computation accuracy.

C. State of the Art About the BP-NGD Performances

The BP-NGD performances of hybrid and distributed 3-port microstrip Y-circuit are, particularly interesting, compared to the other circuits investigated in [22-24]. First of all, the 3-port BP-NGD circuit is designed and investigated in the first time. Table IV recapitulates the comparison between the NGD center frequency, NGD value, bandwidth and reflection attenuation loss at the NGD center frequency.

TABLE IV
COMPARISON OF BP NGD PERFORMANCES

Ref.	Type	f_n (MHz)	$GD(f_n)$ (ns)	BW (MHz)	$T(f_n)$ (dB)
[22]	2-port	1200	-2.8	13	-2.2
[23]	2-port	1150	-2.2	15	-1.93
[24]	3-port	550	-18.12	1.35	-2.95
This work	①-②	737	-3.87	78	-3.11
	①-③	667	-4.9	64	-0.63

It can be pointed out that compared to the NGD circuits designed in [22-24], the proposed Y-circuit allows to achieve: a) the ability to generate BP-NGD function through both ways ①-② and ①-③, b) a very good attenuation showing low attenuation loss especially through way ①-③, and c) the distributed Y-circuit is merely built with a fully distributed circuit without using any reactive lumped elements.

D. Discussion on BP-NGD Application

Today, communication circuits [7-23] are victim of delay attacks. Against this bottlenecking issue of modern technology, the NGD function is well-placed as a best candidate. We are currently developing several applications of the BP-NGD circuits [22-24] for the future communication transceiver system. Following the topic of the present study, we can state the following application. For example, thanks to the NGD Y-circuit design possibility, we can develop a multi-way circuit delay effect reduction.

1) Brief Description of Skew Reduction NGD Application

Based on the NGD technique introduced in [25], the skew effect of communication circuit can be reduced. The deontological solution consists of cascading the victim circuit by NGD one. It is well-known that under good matching condition, the total TF is ideally equal to the product of cascaded elementary ones. Because of this property, the positive GD and NGDs of cascaded circuits can be cancelled out each other.

Based on the present research work the delay reduction technique can be extended to multi-port circuit with our multi-way NGD topology. Therefore, one of potential future applications of the proposed 3-port circuit is a) the skew compensation and cancellation; b) signal desynchronization against electrical interconnect trees of electronic and communication system; c) delay difference suppression by using a specifically sized three-port BP-NGD topology; and d) solve problem of signal synchronization.

2) Brief Description of Jitter NGD Correction

A feasibility study enables to state that NGD circuits can be applied to correct microwave signal distortion [26]. With such

a technique, the Jitter and associated phase noise of high-speed communication devices due to the interconnections can be corrected by using reconfigurable NGD circuits. The distributed topologies are good candidate for this solution because of possibilities to operate at tens GHz.

3) *Brief Description of Resonance Effect Reduction*

Because of integration density, electric and electronic systems are more and more designed and implemented in confined space which generate undesirably dramatic resonance effects. As reported in [27-28], the NGD function is useful in the EMC engineering as approved by the EM resonance reduction feasibility study. Indeed, the BP NGD circuit can equalize the resonance TF. Then, the magnitude peak and also the GD are naturally attenuated.

IV. CONCLUSION

An innovative BP-NGD design method of 3-port topology is investigated. The feasibility study to generate BP-NGD effect through the double output branches is performed. The considered topology is essentially constituted by TL elements with output branch terminated by resistor components. After the recall on the BP-NGD specification, an innovative modelling method of the 3-port circuit is developed. The double branch frequency-dependent VTFs are expressed by means of transfer matrix analysis. Afterwards, the GDs through the 3-port topology transmission ways are expressed in function of the TL parameters.

The validation is carried with POC and prototype implemented in hybrid technology. A challenging VTF measurement technique is described. After successful test, it was found that the BP-NGD function is corroborated by analytical calculation, simulation and measurement results in very good correlation. The BP-NGD performances from the present work are compared with the literature [22-24].

The 3-port circuit BP-NGD applications notably for the future communication system are discussed.

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